

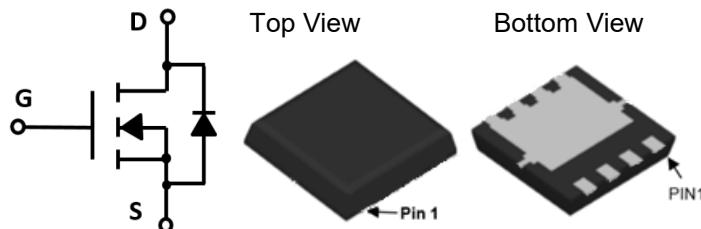
## Description

The CMN3006F3 is the N-Channel enhancement mode power field effect transistors with high cell density, trench technology. This high density process and design have been optimized switching performance and especially tailored to minimize on-state resistance.

## Features

- V<sub>DS</sub>: 30V
- I<sub>D</sub>: 43A
- R<sub>DS(on)</sub> (@V<sub>GS</sub>=10V) : < 6.0mΩ
- R<sub>DS(on)</sub> (@V<sub>GS</sub>=4.5V) : < 8.0mΩ
- High density cell design for extremely low R<sub>DS(on)</sub>
- Excellent on-resistance and DC current capability

## Equivalent Circuit and Pin Configuration



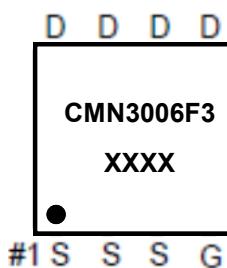
## Absolute Maximum Ratings (TA=25 °C unless otherwise noted)

Parameter	Symbol	Maximum	Unit
Drain-source Voltage	V <sub>DS</sub>	30	V
Gate-source Voltage	V <sub>GS</sub>	±20	V
Drain Current <sup>(1)(6)</sup>	I <sub>D</sub>	43	A
		27	A
	I <sub>D</sub>	18	A
		11	A
Pulsed Drain Current <sup>(3)</sup>	I <sub>DM</sub>	172	A
Total Power Dissipation <sup>(4)</sup>	P <sub>D</sub>	18	W
		3	W
Thermal Resistance Junction-to-Ambient <sup>(2)(5)</sup>	R <sub>θJA</sub>	40	°C/W
Thermal Resistance Junction-to-Case	R <sub>θJC</sub>	7	°C/W
Junction and Storage Temperature Range	T <sub>J,TSTG</sub>	-55 to +150	°C

## Applications

- Battery management
- Power management
- Load switch

## Marking Information



Marking Code = CMN3006F3

Date Code = XXXX

## Ordering Information

Part Number	Packaging	Reel Size
CMN3006F3	5000/Tape & Reel	13 inch

**Electrical Characteristics (T<sub>J</sub>=25 °C unless otherwise noted)**

Parameter	Symbol	Conditions	Min	Typ	Max	Units
<b>Static Parameter</b>						
Drain-Source Breakdown Voltage	BVDSS	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	30			V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V, V <sub>GS</sub> =0V, T <sub>C</sub> =25°C			1	μA
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V			±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA	1.0		3.0	V
Static Drain-Source on-Resistance	R <sub>D(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =15A		4.9	6.0	mΩ
		V <sub>GS</sub> =4.5V, I <sub>D</sub> =15A		6.3	8.0	
Diode Forward Voltage	V <sub>SD</sub>	I <sub>S</sub> =20A, V <sub>GS</sub> =0V			1.2	V
Maximum Body-Diode Continuous Current	I <sub>S</sub>				43	A
<b>Dynamic Parameters</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f=1MHz		2130		pF
Output Capacitance	C <sub>oss</sub>			265		
Reverse Transfer Capacitance	C <sub>rss</sub>			200		
<b>Switching Parameters</b>						
Total Gate Charge	Q <sub>g</sub>	V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A		41		nC
Gate Source Charge	Q <sub>gs</sub>			5.9		
Gate Drain Charge	Q <sub>gd</sub>			8.8		
Turn-on Delay Time	t <sub>D(on)</sub>	V <sub>GS</sub> =10V, V <sub>DD</sub> =20V, I <sub>D</sub> =4A, R <sub>L</sub> =1Ω, R <sub>GEN</sub> =3Ω		9		ns
Turn-on Rise Time	t <sub>r</sub>			15.5		
Turn-off Delay Time	t <sub>D(off)</sub>			29		
Turn-off Fall Time	t <sub>f</sub>			9		

Noted: (1) Pulse Test: Pulse Width≤300us,Duty cycle ≤2%.

- (2) The value of R<sub>θJA</sub> is measured with the device mounted on lin2 FR-4 board with 2oz.Copper,in a still air environment with T<sub>A</sub> =25°C.The Power dissipation PDSM is based on R<sub>θJA</sub> t≤10s and the maximum allowed junction temperature of 150°C.The value in any given application depends on the user's specific board design.
- (3) Single pulse width limited by junction temperature T<sub>J(MAX)</sub> = 150°C.
- (4) The power dissipation PD is based on T<sub>J(MAX)</sub> = 150°C,using junction-to-case thermal resistance, and is more useful in setting the upper Dissipation limit for cases where additional heatsinking is used.
- (5) The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJA</sub> and case to ambient.
- (6) The maximum current rating is package limited.

## Typical Performance Characteristics

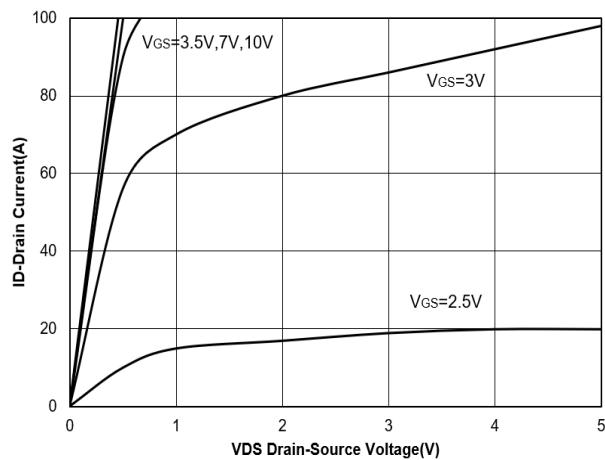


Figure 1. Output Characteristics

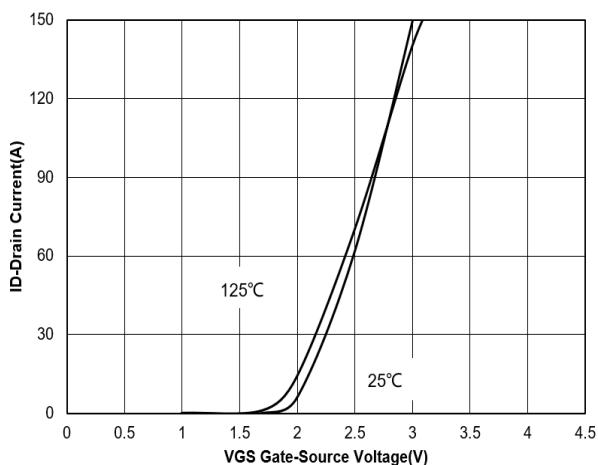


Figure 2. Transfer Characteristics

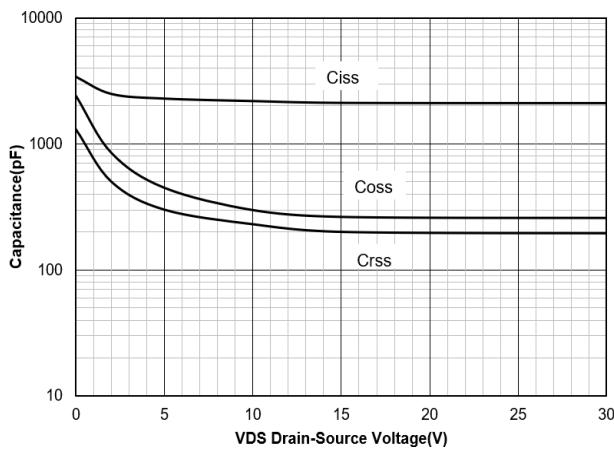


Figure 3. Capacitance Characteristics

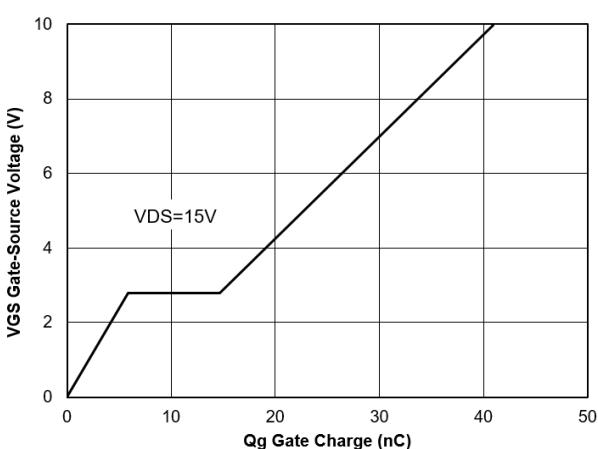


Figure 4. Gate Charge

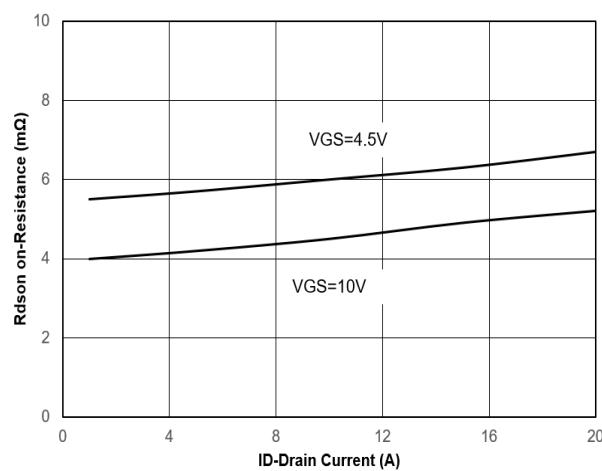


Figure 5. Drain-Source on Resistance

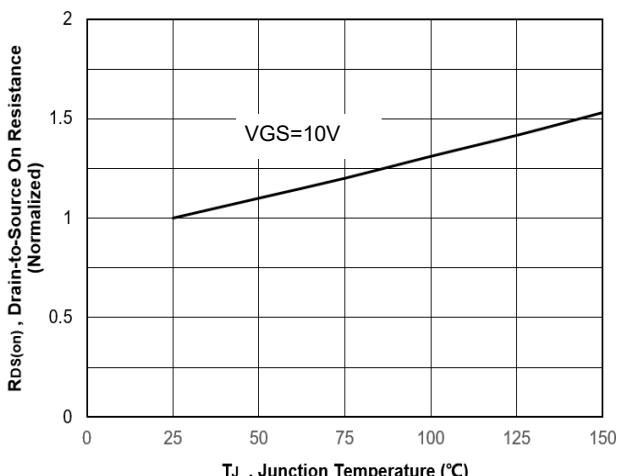


Figure 6. Normalized On-Resistance

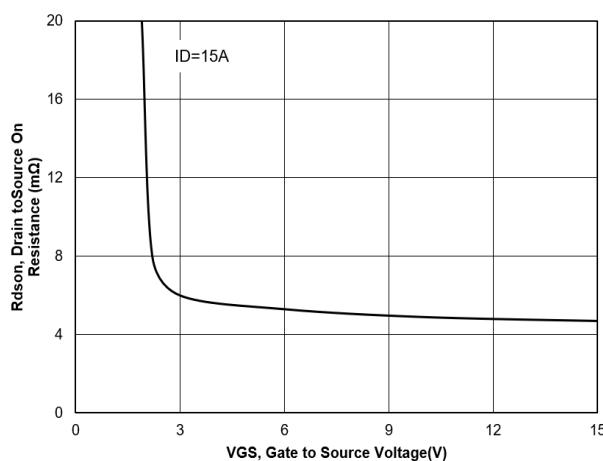


Figure 7. Typical Drain to Source ON Resistance  
VS Gate Voltage and Drain Current

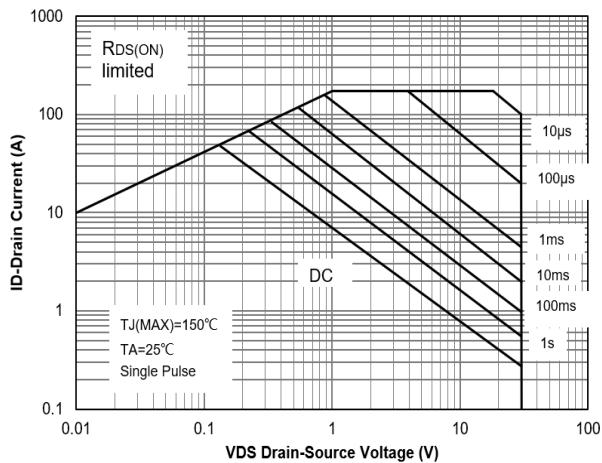


Figure 8. Safe Operation Area

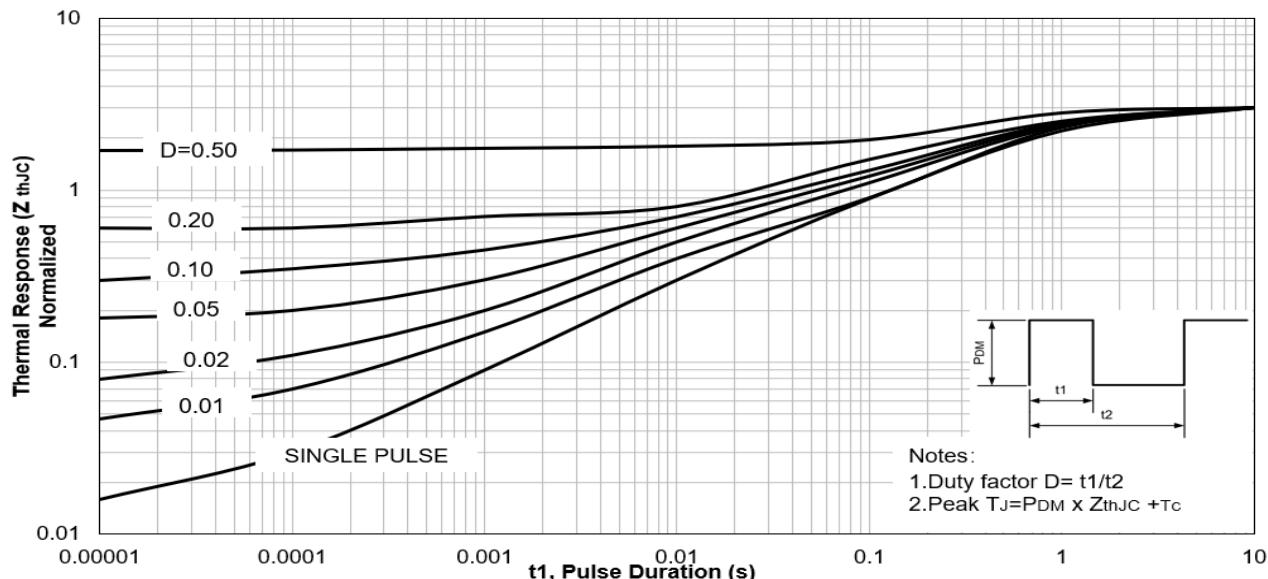


Figure 9. Maximum Effective Transient Thermal Impedance, Junction-to-Case

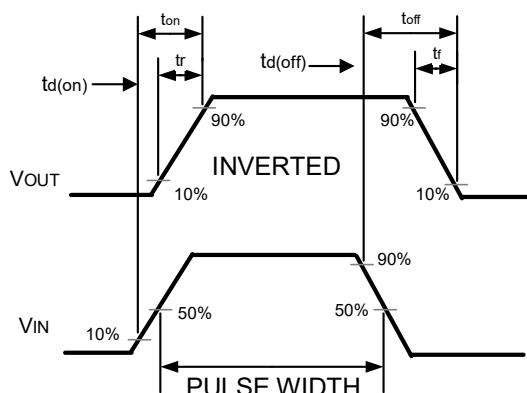
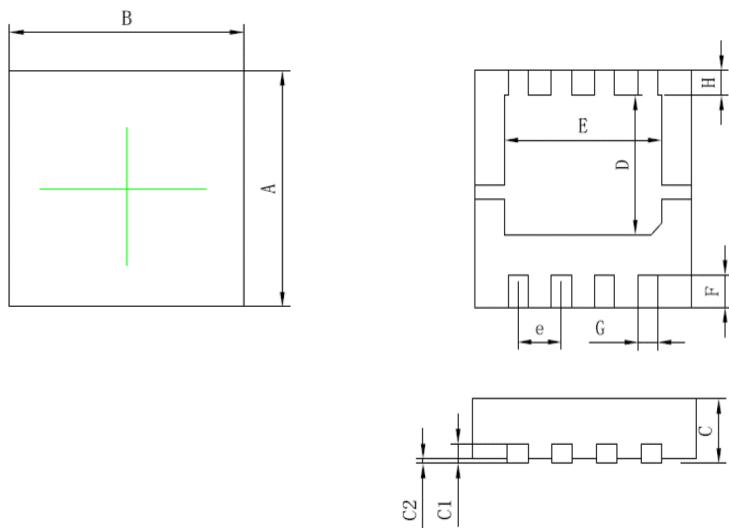


Figure 10. Switching wave

### DFN 3.3x3.3 Package Outline Drawing



Symbol	Millimeters	
	Min.	Max.
A	3.20	3.30
B	3.20	3.30
C	0.75	0.85
C1	0.18	0.22
C2	--	0.05
D	1.80	2.00
E	2.20	2.50
F	0.40	0.50
G	0.25	0.35
H	0.30	0.40
e	0.60	0.70

### Contact Information

Applied Power Microelectronics Inc.

Website: <http://www.appliedpowermicro.com>

Email: [sales@appliedpowermicro.com](mailto:sales@appliedpowermicro.com)

Phone: +86 (0519) 8399 3606

Applied Power Microelectronics Inc. (APM) reserves the right to make changes to the product specification and data in this document without notice. APM makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does APM assume any liability arising from the application or use of any products or circuits, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages.